

Notice of References Cited

Application/Control No
09/991,973

Applicant(s)/Patent Under
Reexamination
KIM ET AL

Examiner
A Sefer

Art Unit
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,215,244	04-2002	Kuribayashi et al	313/505
	B	US- 2001/0011868	08-2001	Fukunaga et al	313/506
	C	US-2001/0043046	11-2001	Fukunaga	315/160
	D	US-5,856,858	01-1999	Carey et al	349/158
	E	US-5,177,577	01-1993	Taniguchi et al	257/59
	F	US-6,046,547	04-2000	Nishio et al	315/169.3
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 10-68955	03-1998	Japan	Hasegawa et al	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		include as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Page(s)
	J	
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	X	

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